MOSFET – Power, Dual, N-Channel 40 V, 11.5 mΩ, 36 A

Features

- Small Footprint (5x6 mm) for Compact Design
- Low R_{DS(on)} to Minimize Conduction Losses
- Low Q_G and Capacitance to Minimize Driver Losses
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

| Parameter | | | Symbol | Value | Unit |
|--|-------------------------------------|------------------------|-----------------------------------|-----------------|------|
| Drain-to-Source Voltage | | | V_{DSS} | 40 | V |
| Gate-to-Source Voltage | Э | | V _{GS} | ±20 | V |
| Continuous Drain | | T _C = 25°C | I _D | 36 | Α |
| Current R _{θJC} (Notes 1, 2, 3) | Steady | T _C = 100°C | | 23 | |
| Power Dissipation | State | T _C = 25°C | P_{D} | 24 | W |
| R _{θJC} (Notes 1, 2) | | T _C = 100°C | | 12 | |
| Continuous Drain | | T _A = 25°C | I _D | 11 | Α |
| Current R _{θJA} (Notes 1, 2, 3) | Steady | T _A = 100°C | | 8.0 | |
| Power Dissipation | State T _A = 25°C | | P_{D} | 3.0 | W |
| R _{θJA} (Notes 1 & 2) | | T _A = 100°C | | 1.5 | |
| Pulsed Drain Current | $T_A = 25^{\circ}C, t_p = 10 \mu s$ | | I _{DM} | 110 | Α |
| Operating Junction and Storage Temperature | | | T _J , T _{stg} | –55 to + 175 | °C |
| Source Current (Body Diode) | | | I _S | 15 | Α |
| Single Pulse Drain-to-Source Avalanche Energy ($T_J = 25$ °C, $I_{L(pk)} = 2 \text{ A}$) | | | E _{AS} | 49 | mJ |
| Lead Temperature for Soldering Purposes (1/8" from case for 10 s) | | | TL | 260 | °C |

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

THERMAL RESISTANCE MAXIMUM RATINGS

| Parameter | Symbol | Value | Unit |
|---|-----------------|-------|------|
| Junction-to-Case - Steady State | $R_{\theta JC}$ | 5.3 | °C/W |
| Junction-to-Ambient - Steady State (Note 2) | $R_{\theta JA}$ | 49 | |

- The entire application environment impacts the thermal resistance values shown, they are not constants and are only valid for the particular conditions noted.
- 2. Surface-mounted on FR4 board using a 650 mm², 2 oz. Cu pad.
- 3. Maximum current for pulses as long as 1 second is higher but is dependent on pulse duration and duty cycle.

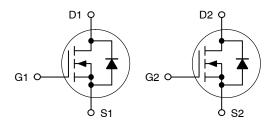


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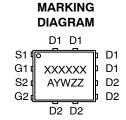
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| V _{(BR)DSS} | R _{DS(ON)} MAX | I _D MAX | |
|----------------------|-------------------------|--------------------|--|
| 40 V | 11.5 mΩ @ 10 V | 36 A | |
| | 17.8 mΩ @ 4.5 V | | |

Dual N-Channel







A = Assembly Location

= Year

W = Work Week
ZZ = Lot Traceability

ORDERING INFORMATION

See detailed ordering, marking and shipping information in the package dimensions section on page 5 of this data sheet.

ELECTRICAL CHARACTERISTICS (T_J = 25°C unless otherwise specified)

| Section | Unit | Max | Тур | Min | Test Condition | | Symbol | Parameter |
|---|---------|------|------|-----|--|--|-------------------------------------|--|
| Drain-to-Source Breakdown Voltage Temperature Coefficient | • | | | | | | | OFF CHARACTERISTICS |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | V | | | 40 | V _{GS} = 0 V, I _D = 250 μA | | V _{(BR)DSS} | Drain-to-Source Breakdown Voltage |
| V _{DS} = 40 V T _J = 125°C 10 10 | mV/°C | | 24 | | | | V _{(BR)DSS} / | |
| Gate-to-Source Leakage Current I _{GSS} V _{DS} = 0 V, V _{GS} = 20 V 10 10 | | 10 | | | T _J = 25 °C | V _{GS} = 0 V, | I _{DSS} | Zero Gate Voltage Drain Current |
| ON CHARACTERISTICS (Note 4) Gate Threshold Voltage $V_{GS(TH)}$ $V_{GS} = V_{DS}$, $I_D = 20 \mu A$ 1.2 2. Negative Threshold Temperature Coefficient $V_{GS(TH)}/T_J$ $V_{GS} = 10 \text{ V}$ $I_D = 5 \text{ A}$ 9.2 11 Drain-to-Source On Resistance $R_{DS(on)}$ $V_{GS} = 10 \text{ V}$ $I_D = 5 \text{ A}$ 9.2 11 Forward Transconductance g_{FS} $V_{DS} = 15 \text{ V}$, $I_D = 15 \text{ A}$ 30 30 CHARGES, CAPACITANCES & GATE RESISTANCE Input Capacitance C_{ISS} $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $V_{DS} = 25 \text{ V}$ 200 20 Reverse Transfer Capacitance C_{RSS} $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$, $V_{DS} = 25 \text{ V}$ 200 30.0 Total Gate Charge $Q_{G(TO)}$ $V_{GS} = 4.5 \text{ V}$, $V_{DS} = 32 \text{ V}$, $I_D = 15 \text{ A}$ 4.0 4.0 Total Gate Charge $Q_{G(TO)}$ $V_{GS} = 10 \text{ V}$, $V_{DS} = 32 \text{ V}$, $I_D = 15 \text{ A}$ 4.0 4.0 Threshold Gate Charge Q_{GC} Q_{GC} 1.1 4.0 4.0 Gate-to-Drain Charge Q_{GD} $V_{GS} = 4.5 \text{ V}$, $V_{DS} $ | μΑ | 100 | | | T _J = 125°C | V _{DS} = 40 V | | |
| Gate Threshold Voltage $V_{GS(TH)}$ $V_{GS} = V_{DS}$, $I_D = 20$ μA 1.2 2.2 Negative Threshold Temperature Coefficient $V_{GS(TH)}/J_J$ —4.5 Drain-to-Source On Resistance $P_{DS(on)}$ $V_{GS} = 10$ V $I_D = 5$ A 9.2 11 Forward Transconductance g_{FS} $V_{DS} = 15$ V, $I_D = 15$ A 30 30 CHARGES, CAPACITANCES & GATE RESISTANCE Input Capacitance C_{ISS} $V_{DS} = 15$ V, $I_D = 15$ A 590 Output Capacitance C_{OSS} $V_{GS} = 0$ V, $f = 1$ MHz, $V_{DS} = 25$ V 200 Reverse Transfer Capacitance C_{RSS} $V_{GS} = 0$ V, $f = 1$ MHz, $V_{DS} = 25$ V 200 Total Gate Charge $Q_{G(TOT)}$ $V_{GS} = 4.5$ V, $V_{DS} = 32$ V; $I_D = 15$ A 4.0 Threshold Gate Charge $Q_{G(TOT)}$ $V_{GS} = 10$ V, $V_{DS} = 32$ V; $I_D = 15$ A 9.0 Threshold Gate Charge Q_{GD} $V_{GS} = 4.5$ V, $V_{DS} = 32$ V; $I_D = 15$ A 1.6 Gate-to-Drain Charge Q_{GD} $V_{GS} = 4.5$ V, $V_{DS} = 32$ V, V_{DS} | nA | 100 | | | = 20 V | V _{DS} = 0 V, V _{GS} | I _{GSS} | Gate-to-Source Leakage Current |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | | | | | | ON CHARACTERISTICS (Note 4) |
| Drain-to-Source On Resistance R _{DS(on)} V _{GS} = 10 V I _D = 5 A 9.2 11 | 2 V | 2.2 | | 1.2 | $V_{GS} = V_{DS}$, $I_D = 20 \mu A$ | | V _{GS(TH)} | Gate Threshold Voltage |
| $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | mV/°C | | -4.5 | | | | V _{GS(TH)} /T _J | Negative Threshold Temperature Coefficient |
| Forward Transconductance | | 11.5 | 9.2 | | I _D = 5 A | V _{GS} = 10 V | R _{DS(on)} | Drain-to-Source On Resistance |
| $ \begin{array}{ c c c c c } \hline \textbf{Charges, CaPaCitances & Gate Resistance} \\ \hline \textbf{Input Capacitance} & \textbf{C}_{ISS} \\ \hline \textbf{Output Capacitance} & \textbf{C}_{OSS} \\ \hline \textbf{Reverse Transfer Capacitance} & \textbf{C}_{RSS} \\ \hline \textbf{Total Gate Charge} & \textbf{Q}_{G(TOT)} \\ \hline \textbf{Total Gate Charge} & \textbf{Q}_{G(TOT)} \\ \hline \textbf{V}_{GS} = 4.5 \text{ V, V}_{DS} = 32 \text{ V; I}_{D} = 15 \text{ A} \\ \hline \textbf{Q}_{GC} \\ \hline \textbf{SWITCHING CHARACTERISTICS} \\ \hline Note In the part of the par$ | mΩ 8 | 17.8 | 14.6 | | I _D = 5 A | V _{GS} = 4.5 V | | |
| | S | | 30 | | = 15 A | V_{DS} = 15 V, I_{D} | 9FS | Forward Transconductance |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | | | | | STANCE | CHARGES, CAPACITANCES & GATE RESIS |
| Reverse Transfer Capacitance C_{RSS} 8.0 Total Gate Charge $Q_{G(TOT)}$ $V_{GS} = 4.5 \text{ V}$, $V_{DS} = 32 \text{ V}$; $I_D = 15 \text{ A}$ 4.0 Total Gate Charge $Q_{G(TOT)}$ $V_{GS} = 10 \text{ V}$, $V_{DS} = 32 \text{ V}$; $I_D = 15 \text{ A}$ 9.0 Threshold Gate Charge $Q_{G(TH)}$ 1.1 1.1 Gate-to-Source Charge Q_{GS} 2.2 2.2 Gate-to-Drain Charge Q_{GD} 1.6 1.6 Plateau Voltage V_{GP} 3.2 3.2 SWITCHING CHARACTERISTICS (Note 5) $V_{GS} = 4.5 \text{ V}$, $V_{DS} = 32 \text{ V}$, V_{D | | | 590 | | V _{GS} = 0 V, f = 1 MHz, V _{DS} = 25 V | | C _{ISS} | Input Capacitance |
| | pF | | 200 | | | | C _{OSS} | Output Capacitance |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 8.0 | | | | C _{RSS} | Reverse Transfer Capacitance |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 4.0 | | V _{GS} = 4.5 V, V _{DS} = 32 V; I _D = 15 A | | Q _{G(TOT)} | Total Gate Charge |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 9.0 | | V _{GS} = 10 V, V _{DS} = 32 V; I _D = 15 A | | Q _{G(TOT)} | Total Gate Charge |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | nC | | 1.1 | | | | | Threshold Gate Charge |
| $\begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 2.2 | | $V_{GS} = 4.5 \text{ V}, V_{DS} = 32 \text{ V}; I_D = 15 \text{ A}$ | | Q_{GS} | Gate-to-Source Charge |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 1.6 | | | | Q_{GD} | Gate-to-Drain Charge |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | V | | 3.2 | | | | V_{GP} | Plateau Voltage |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | | | | | | SWITCHING CHARACTERISTICS (Note 5) |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 9.3 | | | | | Turn-On Delay Time |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | | | 55 | | s = 32 V, | V _{GS} = 4.5 V, V _{DS} | t _r | Rise Time |
| $ \begin{array}{c ccccccccccccccccccccccccccccccccccc$ | ns | | 20 | | = 1.0 Ω | $I_D = 15 \text{ A}, R_G = 1.0 \Omega$ | | Turn-Off Delay Time |
| Forward Diode Voltage V_{SD} $V_{GS} = 0 \text{ V}, \\ I_{S} = 5 \text{ A}$ $T_{J} = 25^{\circ}\text{C}$ 1.0 1.3 1.3 1.3 1.3 1.3 1.3 1.3 1.4 1.5 1.5 1.5 1.5 1.5 1.5 1.5 1.5 1.5 1.5 | | | 36 | | | | t _f | Fall Time |
| $I_{S} = 5 \text{ A}$ $T_{J} = 125^{\circ}\text{C}$ 0.8 | | | | | | | s | DRAIN-SOURCE DIODE CHARACTERISTIC |
| $I_S = 5 \text{ A}$ $T_J = 125^{\circ}\text{C}$ 0.8 | | 1.2 | 1.0 | | T _J = 25°C | V _{GS} = 0 V, | V_{SD} | Forward Diode Voltage |
| Payarra Pagayary Time | | | 0.8 | | T _J = 125°C | $I_S = 5 \text{ A}$ | $I_S = 5$ | |
| nevelse necovery little RR 20 | | | 20 | | $V_{GS} = 0 \text{ V, } dI_{S}/dt = 100 \text{ A/}\mu\text{s,}$ $I_{S} = 15 \text{ A}$ | | t _{RR} | Reverse Recovery Time |
| Charge Time $t_a = V_{GS} = 0 \text{ V, } dI_S/dt = 100 \text{ A/}\mu\text{s},$ | ns | | 10 | | | | t _a | Charge Time |
| | | | 10 | | | | t _b | Discharge Time |
| Reverse Recovery Charge Q _{RR} 9 | nC | | 9 | | | | Q _{RR} | Reverse Recovery Charge |

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

4. Pulse Test: pulse width $\leq 300~\mu s$, duty cycle $\leq 2\%$.

5. Switching characteristics are independent of operating junction temperatures.

TYPICAL CHARACTERISTICS

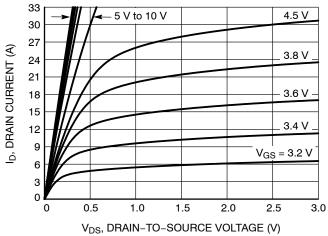


Figure 1. On-Region Characteristics

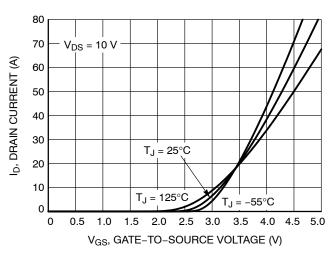


Figure 2. Transfer Characteristics

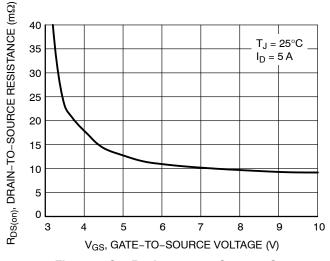


Figure 3. On-Resistance vs. Gate-to-Source Voltage

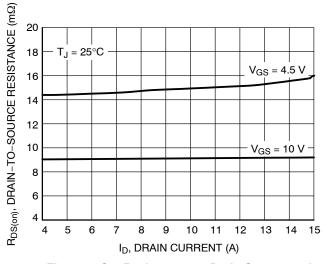


Figure 4. On–Resistance vs. Drain Current and Gate Voltage

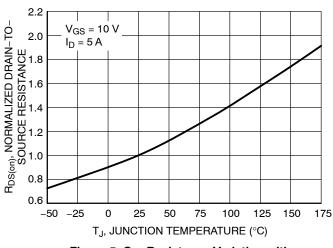


Figure 5. On–Resistance Variation with Temperature

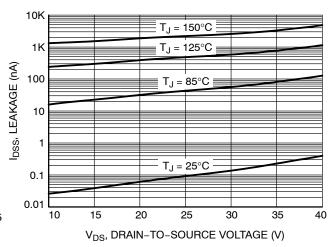


Figure 6. Drain-to-Source Leakage Current vs. Voltage

TYPICAL CHARACTERISTICS

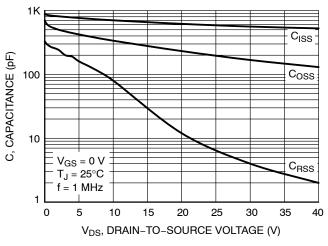


Figure 7. Capacitance Variation

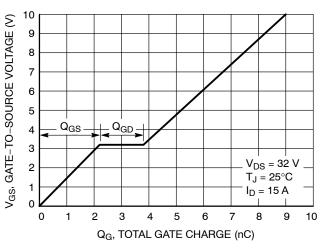


Figure 8. Gate-to-Source vs. Total Charge

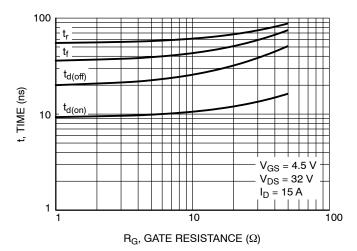


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

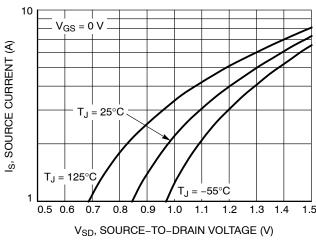


Figure 10. Diode Forward Voltage vs. Current

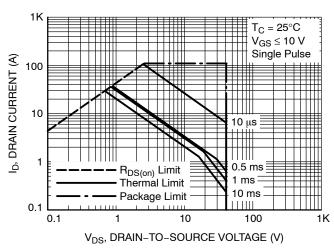


Figure 11. Maximum Rated Forward Biased Safe Operating Area

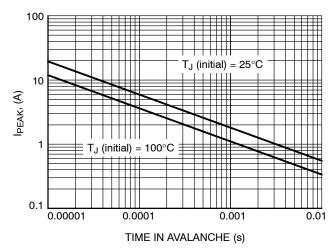


Figure 12. $I_{\mbox{\scriptsize PEAK}}$ vs. Time in Avalanche

TYPICAL CHARACTERISTICS

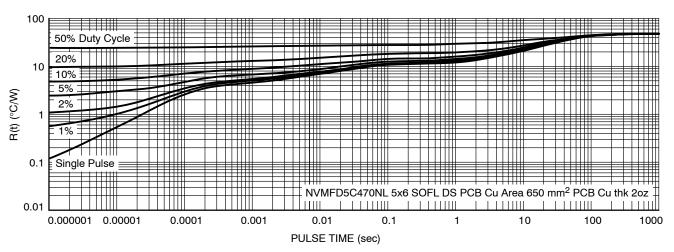


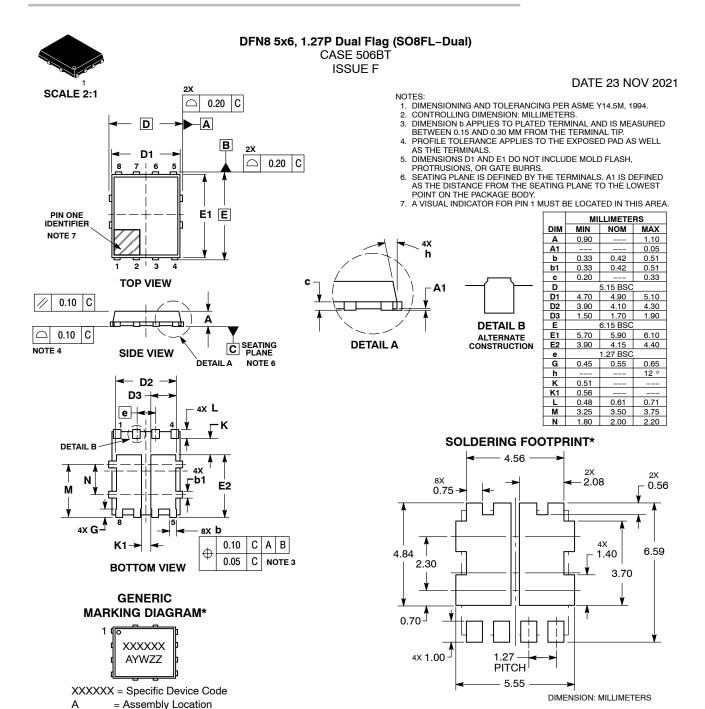
Figure 13. Thermal Characteristics

DEVICE ORDERING INFORMATION

| Device | Marking | Package | Shipping [†] |
|-----------------|---------|-------------------|-----------------------|
| NTMFD5C470NLT1G | 5C470L | DFN8 (Pb-Free) | 1500 / Tape & Reel |

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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|------------------|---|-------------|--|
| DESCRIPTION: | DFN8 5X6, 1.27P DUAL FL | PAGE 1 OF 1 | |

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= Year

not follow the Generic Marking.

= Work Week

= Lot Traceability *This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "=", may or may not be present. Some products may

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ZZ

*For additional information on our Pb-Free strategy and soldering

Mounting Techniques Reference Manual, SOLDERRM/D.

details, please download the ON Semiconductor Soldering and

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